

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/755,378	THORNTON ET AL.
	<b>Examiner</b> Annan Q. Shang	<b>Art Unit</b> 2617

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
725	<b>78-82</b>	12/5/2005	A.S.
725	87-91	12/5/2005	A.S.
709	217-219	12/5/2005	A.S.